

<b>Search Notes</b> 	<b>Application/Control No.</b>	<b>Applicant(s)/Patent under Reexamination</b>
	10/662,325	KOIKE, TERUO
	<b>Examiner</b> Y Quach Lee	<b>Art Unit</b> 2875

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
East	Above	7/7/2005	YMY
PGPUB			